Search Notes

Application/Control No.	Applicant(s)/Patent Under Reexamination
10581752	DEORE ET AL.
Examiner	Art Unit
SHANE FANG	1796

SEARCHED			
Class	Subclass	Date	Examiner
528	422	12/14/2009	sf

SEARCH NOTES		
Search Notes	Date	Examiner
NPL and STIC searched	12/14/2009	sf

INTERFERENCE SEARCH		
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